



<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10750082	VANDERVEEN ET AL.
	Examiner Washburn, Douglas N	Art Unit 2863

Notes	Date	Examiner
Inventor name search - see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW
EAST keyword/keyphrase	06/15/2006	DNW
A61M031/00 see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW
A61M005/14 see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW
G06F015/00 see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW
G06F019/00 see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW
G011O013/00 see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW
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702/98, 100, 127, 138, 140 see printout - (USPGPUB; USPAT; USOCR)	06/15/2006	DNW
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	<p>Examiner</p> <p>Washburn, Douglas N</p>	<p>Art Unit</p> <p>2863</p>

Class	SubClass	Date	Examiner
604	81	06/15/2006	DNW
702	98	06/15/2006	DNW
702	100	06/15/2006	DNW
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